Search Notes



Applicatio	n/	Con	trol	Ñο.

10/720,246 Examiner

JEAN B. FLEURANTIN

Applicant(s)/Patent under Reexamination

KELLER ET AL.

Art Unit

21	62

	SEARCHED		
Class	Subclass	Date	Examiner
707	1-10	8/18/2006	JBF
707	100-104.1	8/18/2006	JBF
707	200-206	8/18/2006	JBF
708	1-3	8/18/2006	JBF
708	6-8	8/18/2006	JBF
715	538	8/18/2006	JBF
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
707	4	8/18/2006	JBF	
707	1 & 100	8/18/2006	JBF	
707	200	8/18/2006	JBF	

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
WEST (US PG PUB, US PT, EPO, JPO, DERWENT AND IBM TDB)	8/18/2006	JBF
707/CCLS AND 708/CCLS	8/18/2006	JBF
NPL - ACM	8/18/2006	JBF
NPL - IEEE	8/18/2006	JBF